

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	18	("2988487" "3751222" "5009485" "5171682" "5711849" "5786023" "5910011" "6232134").PN.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 12:54
S2	2	S1 and fourier	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 12:55
S3	781	204/298.03.ccls. or 204/192.13.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:01
S4	3	S3 and (principle principal) adj component adj analysis	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:09
S5	18	S3 and (compar\$3 with (actual measur \$3) with (reference standard desir\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:11
S6	8	S5 and (wafer LCD (liquid adj crystal))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:17
S7	1	("6232134").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2008/07/23 13:37

S8	0	S3 and (design adj "of" adj experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:47
S9	0	etch\$4 and (design adj "of" adj experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:47
S10	0	etch\$4 and (design adj of adj experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:47
S11	0	(design adj of adj experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/23 13:47
S12	324	("204".clas. or "438". clas.) and (design near4 experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 15:24
S13	301	("204".clas. or "438". clas.) and (design near3 experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 15:25
S14	0	("204".clas. or "438". clas.) and (design near2 of near2 experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 15:25
S15	0	("204".clas. or "438". clas.) and (design near3 of near3 experiment)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 15:25

S16	0	("204".clas. or "438". clas.) and (design\$3 near3 of near3 experiment\$3)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 15:25
S17	0	("204".clas. or "438". clas.) and (design\$3 near3 of near3 experiment\$5)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 15:25
S18	1	(monitor\$4 test\$4).ti. and (spin adj on)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 16:06
S19	3	(feedback near7 control\$3) and (batch adj diffusion)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 16:07
S20	0	(feedback near7 control\$3) and (spin adj on)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 16:07
S21	1	(feedback near7 control\$3) same (fault threshold) and (spin-on-glass)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/28 16:09
S22	5	("204".clas. "438". clas.) and (compar\$3 with (actual measur \$3) with (reference standard desir\$3)) and (multidimension\$3 (multi-dimension\$3) (multi adj dimension \$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 07:39

S23	11	("4192706" "4226665" "4243506" "4297162" "4340461" "5147520" "5330606" "5399229" "5445709").PN. OR ("5711849").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 08:14
S24	1	S23 and (multivariable multivariate (fourier near3 harmonic) (principal adj component) (design near2 experiment))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 08:19
S25	8	S23 and ((thermal adj process\$3) (batch adj diffusion) (diffusion adj furnace) (UV ultraviolet) (photoresist) (dielectric adj coat\$3))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 08:32
S26	22	("4859277" "6054333" "6060329").PN. OR ("6232134").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 08:32
S27	0	S26 and (multivariable multivariate (fourier near3 harmonic) (principal adj component) (design near2 experiment))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 08:34
S28	11	S26 and ((thermal adj process\$3) (batch adj diffusion) (diffusion adj furnace) (UV ultraviolet) (photoresist) (dielectric adj coat\$3))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 08:34
S29	272	spin-on-dielectric	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:28

S30	1	S29 and (compar\$3 with (actual measur\$3) with (reference standard desir\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:28
S31	12	S29 and ((compar\$3 analy\$4) with (actual measur\$3 determin\$3) with (reference standard desir\$3))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:29
S32	34316	spin-on-dielectric SOD	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:30
S33	618	S32 and ((compar\$3 with (actual measur\$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:30
S34	6651	spin-on-dielectric spin-on-glass	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:31
S35	23	S34 and ((compar\$3 with (actual measur\$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 10:31
S36	72	S34 and (feedback near\$4 control\$4)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 13:02
S37	0	S34 and (feedback near\$4 control\$4) same (deposit\$4 near\$5 rate)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 13:08

S38	85	spin adj coat\$4 and (feedback near4 control\$4) same (deposit\$4 near5 rate)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 13:08
S39	4133	"diffusion furnace"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 14:05
S40	3	S39 and (feedback near4 control\$4) and ((compar\$3 with (actual measur\$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 14:06
S41	16	S39 and ((compar\$3 with (actual measur \$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/29 14:07
S42	9	("5807761" "6051348" "6245584" "6306669" "6388756" "6472324" "6524163").PN. OR ("6625514").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 14:09
S43	0	S42 and spin-on	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 14:09
S44	158	"rapid thermal" and ((compar\$3 with (actual measur\$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 14:10
S45	0	((ultraviolet UV) near3 photoresist adj pattern \$4) and ((compar\$3 with (actual measur \$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 15:46

S46	32	((ultraviolet UV) near3 ((photoresist adj pattern\$4) (lithography))) and ((compar\$3 with (actual measur\$3) with (reference standard desir\$3)))	US-PGPUB; USPAT; USOCR	OR	ON	2008/07/29 15:47
S47	8	((thermal adj process \$3) and (batch adj diffusion) and (diffusion adj furnace) and (UV ultraviolet) and (photoresist) and (dielectric adj coat\$3)) and (CVD (chemical adj vapor adj deposition) PVD (physical adj vapor adj deposition) sputter\$5)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/30 10:59
S48	8	((thermal adj process \$3) and ((batch adj diffusion) (diffusion adj furnace)) and (UV ultraviolet) and (photoresist) and (dielectric adj coat\$3)) and (CVD (chemical adj vapor adj deposition) PVD (physical adj vapor adj deposition) sputter\$5)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/30 11:03
S49	42	((rapid adj thermal) (thermal adj process \$3)) and ((batch adj diffusion) (diffusion adj furnace)) and (photoresist) and (spin-on) and (CVD (chemical adj vapor adj deposition) PVD (physical adj vapor adj deposition) sputter\$5)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/30 11:18

S50	77	((rapid adj thermal) (thermal adj process \$3)) and ((batch adj diffusion) (diffusion adj furnace)) and (photoresist) and (spin-on\$6) and (CVD (chemical adj vapor adj deposition) PVD (physical adj vapor adj deposition) sputter\$5)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/30 11:18
S51	18	S49 and (UV ultraviolet)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2008/07/30 11:21

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